

<b>Notice of References Cited</b>	Application/Control No. 10/756,391	Applicant(s)/Patent Under Reexamination OH ET AL.	
	Examiner Joseph L. Perrin, Ph.D.	Art Unit 1746	Page 1 of 1

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*	B	US-5,561,880	10-1996	Allen et al.	8/149.3
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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